



RF TEST REPORT

Applicant	Huawei Device Co., Ltd.
FCC ID	2ATEYJPT-B29
Product	Smart Watch
Model	JPT-B29
Report No.	R2111A0986-R3
Issue Date	November 29, 2021

TA Technology (Shanghai) Co., Ltd. tested the above equipment in accordance with the requirements in **FCC CFR47 Part 15C (2020)**. The test results show that the equipment tested is capable of demonstrating compliance with the requirements as documented in this report.

Keng Tao

Prepared by: Peng Tao

ai Xu

Approved by: Kai Xu

TA Technology (Shanghai) Co., Ltd. No.145, Jintang Rd, Tangzhen Industry Park, Pudong Shanghai, China

TEL: +86-021-50791141/2/3 FAX: +86-021-50791141/2/3-8000



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Number	Test Case	Clause in FCC rules	Verdict			
1	20 dB bandwidth	2.1049	PASS			
2	Frequency Stability Tolerance	15.225(e)	PASS			
3	Radiated Emissions	15.225 (a) (b) (c) (d) and 15.209	PASS			
4	Conducted Emissions	15.207	PASS			
Date of Testing: November 9, 2021~ November 22, 2021						
Date of Sample Received: November 8, 2021						
Note: PASS: The EUT complies with the essential requirements in the standard.						
FAIL: The EUT does not comply with the essential requirements in the standard.						
All indication	All indications of Pass/Fail in this report are opinions expressed by TA Technology (Shanghai) Co., Ltd.					
based on i	based on interpretations and/or observations of test results. Measurement Uncertainties were not taken					
into accour	nt and are published for informational purpose	s only.				

Summary of measurement results



1. Test Laboratory

1.1. Notes of the test report

This report shall not be reproduced in full or partial, without the written approval of **TA technology** (shanghai) co., Ltd. The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein. Measurement Uncertainties were not taken into account and are published for informational purposes only. This report is written to support regulatory compliance of the applicable standards stated above. This report must not be used by the client to claim product certification, approval, or endorsement by any government agencies.

1.2. Test facility

FCC (Designation number: CN1179, Test Firm Registration Number: 446626)

TA Technology (Shanghai) Co., Ltd. has been listed on the US Federal Communications Commission list of test facilities recognized to perform electromagnetic emissions measurements.

A2LA (Certificate Number: 3857.01)

TA Technology (Shanghai) Co., Ltd. has been listed by American Association for Laboratory Accreditation to perform electromagnetic emission measurement.

1.3. Testing Location

Company:	TA Technology (Shanghai) Co., Ltd.
Address:	No.145, Jintang Rd, Tangzhen Industry Park, Pudong
City:	Shanghai
Post code:	201201
Country:	P. R. China
Contact:	Xu Kai
Contact: Telephone:	Xu Kai +86-021-50791141/2/3
Telephone:	+86-021-50791141/2/3



2. General Description of Equipment under Test

2.1. Applicant and Manufacturer Information

Applicant	Huawei Device Co., Ltd.	
Applicant address	No.2 of Xincheng Road, Songshan Lake Zone, Dongguan, Guangdong 523808, People's Republic of China	
Manufacturer Huawei Device Co., Ltd.		
Manufacturer address	No.2 of Xincheng Road, Songshan Lake Zone, Dongguan, Guangdong 523808, People's Republic of China	

2.2. General information

		EUT Desc	cription			
Model	Iodel JPT-B29					
SN EEDTQ21915000002						
Hardware Versi	on	R0				
Software Versio	n	2.1.0.197SP1				
Power Supply:		Battery				
Antenna Type:		Internal Anter	nna			
Antenna Conne	ctor		y attached ante 203 requiremer	i i	h the standa	ırd
Test Mode:		NFC-A	NFC-B	NFC-F	NFC-V	
Modulation Typ	e:	ASK ASK, BPSK ASK ASK				
Operating Frequency Range(s) 13.56MHz						
Rated Power Supply Voltage 3.82V						
Operating Volta	ge	Minimum: 3.5	V Maximum	: 4.4V		
Operating Temp	perature	Lowest: -20°C	C Highest: +	-45°C		
Testing Tempera	ature	Lowest: -20°C	C Highest: +	-45°C		
		EUT Acc	essory			
Accessory	Model		Manufa	cture		No.
	HB532729ECW	Tradema	ark: Huawei Te	chnologies Co	., Ltd.	1
Battery	HD532729ECW	Factory: Tianjin lishen battery joint-stock Co.,LTD.				1
Ballery	HB532729ECW	Trademark: Huawei Technologies Co., Ltd.			o., Ltd.	2
	1103327292000	Factory: Dongguan NVT Technology Co.,LTD.				2
Charging dock CP81-1 Huawei Device Co., Ltd.				1		
Note: 1. The EL	Note: 1. The EUT is sent from the applicant to TA and the information of the EUT is declared by					
the applicant.	the applicant.					
	ore than one Batter		• •	•	•	e test
respectively, ho	wever, only the wo	orst case (Batte	ry 2) will be rec	orded in this i	eport.	



3. Applied Standards

According to the specifications of the manufacturer, it must comply with the requirements of the following standards:

Test standards:

FCC CFR47 Part 15C (2020)

ANSI C63.10 (2013)

Reference standard:

FCC CFR47 Part 2 (2020)



4. Test Configuration

Test Mode

The EUT has been associated with peripherals and configuration operated in a manner tended to maximize its emission characteristics in a typical application.



5. Test Case Results

5.1. 20dB Bandwidth

Ambient condition

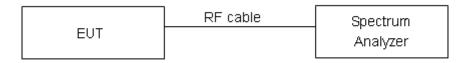
Temperature	Relative humidity	Pressure
23°C ~25°C	45%~50%	101.5kPa

Method of Measurement

The EUT was connected to the spectrum analyzer through an external attenuator (20dB) and a known loss cable. RBW is set to 10 kHz; VBW is set to 3 times the RBW on spectrum analyzer.

Note: Because the measured signal is CW or CW-like adjusting the RBW per C63.10 would not be practical since measured bandwidth will always follow the RBW and the result will be approximately twice the RBW.

Test Setup



Limits

No specific occupied bandwidth requirements in part 2.1049.

Measurement Uncertainty

The assessed measurement uncertainty to ensure 95% confidence level for the normal distribution is with the coverage factor k = 2, U = 936 Hz.



Test Results:

NFC-A

Carrier frequency	99% Bandwidth	20dB Bandwidth	Conclusion
(MHz)	(kHz)	(kHz)	
13.56MHz	25.495	26.90	PASS

NFC-B

Carrier frequency	99% Bandwidth	20dB Bandwidth	Conclusion
(MHz)	(kHz)	(kHz)	
13.56MHz	23.873	26.71	PASS

NFC-F

Carrier frequency	99% Bandwidth	20dB Bandwidth	Conclusion
(MHz)	(kHz)	(kHz)	
13.56MHz	24.462	27.03	PASS

NFC-V

Carrier frequency	99% Bandwidth	20dB Bandwidth	Conclusion
(MHz)	(kHz)	(kHz)	
13.56MHz	25.808	26.97	PASS



All 13 Livit productions for a factor of the second of the		NFC-A				NFC-B		
endeds Ref 30.0 dBm and def ref 30.0 dBm a	Points 1001	Conter Free: 13 560000 MHz Trig: Free Run Avg Hold:	Radio Std: None 10/10 Radio Device: BTS	Sweep Time 2.53 ms	Points 1001	Center Freq: 13 560000 MHz Trig: Free Run Avg Hold:	Radio Std: None 10/10 Radio Device: BTS	Sweep/Control Sweep Tin 2.63 n Auto Ni
NFC- BV Occupied Bandwidth Total Power 15.3 dBm Cath Occupied Bandwidth Total Power 15.3 dBm Cath Cath Transmit Freq Brior 564 Hz 0BW Power 98.00 % Points NFC-F NFC-F NFC-F NFC-F NFC-F NFC-V NFC 101 Cath Cath Cath Value Value Age Points Cath Value Value Cath Cath Value Value Value Cath Value Value Value Value Value Value Value Valu				Sweep Setup ►				Sweep Setu Pau
Transmit Freq Error S64 Hz OBW Power 98.00 % x dB Bandwidth 26.90 kHz x dB -20.00 dB Power 98.00 % x dB Bandwidth 26.90 kHz x dB -20.00 dB Power 98.00 % x dB Bandwidth 26.71 kHz x dB -20.00 dB Power 98.00 % x dB Bandwidth 26.71 kHz x dB -20.00 dB Power 98.00 % x dB Bandwidth 26.71 kHz x dB -20.00 dB Power 98.00 % x dB Bandwidth 26.71 kHz x dB -20.00 dB Power 98.00 % x dB Bandwidth 26.71 kHz x dB -20.00 dB Power 98.00 % x dB Bandwidth 26.71 kHz x dB -20.00 dB Power 98.00 % x dB Bandwidth 26.71 kHz x dB -20.00 dB Power 10.00 m Power 98.00 % x dB Bandwidth 26.71 kHz x dB -20.00 dB Power 10.00 m Power 10.00 kHz	Res BW 10 kHz		Sweep 2.533 ms	Gate	#Res BW 10 kHz		Sweep 2.533 ms	Gate
Adds Section Andyrer. Second Bit Do section Tree: 15 6000 MHz Bit Galactor Bit Gala	Transmit Freq Error	564 Hz OBW Power	-20.00 dB	Points	Transmit Freq Error	581 Hz OBW Power	-20.00 dB	[017, L0] Poin 10
IN IN <th< td=""><td></td><td>NFC-F</td><td></td><td></td><td></td><td>NFC-V</td><td></td><td></td></th<>		NFC-F				NFC-V		
o distav Ref 30.00 dBm o distav Ref 30.00 dBm Sweep Setup Pause Paus	8F 50 Ω AC 0 oints 1001	CORREC SENSEINT Center Freq: 13.560000 MHz Trig: Free Run Avg Hold:	10/10 Radio Std: None Radio Device: BTS	Sweep Time 2.63 ms	07 BF 50 Q AC 0 Points 1001	CORREC SENSE:IVT Center Freq: 13.560000 MHz Trig: Free Run Avg/Hold:	Radio Std: None 10/10 Radio Device: BTS	Sweep/Contro Sweep Tit 2.53
Res BW 10 kHz #VBW 30 kHz Sweep 2.533 ms #Res BW 10 kHz #VBW 30 kHz Sweep 2.533 ms Occupied Bandwidth Total Power 17.9 dBm Gate, [OH, L0] Occupied Bandwidth Total Power 15.2 dBm Cocupied Bandwidth Total Power 15.2 dBm Cocupied Bandwidth Total Power 15.2 dBm Cocupied Bandwidth Cocupied Bandwidth Total Power 15.2 dBm Cocupied Bandwidth 25.808 kHz Cocupied Bandwidth 20.00 kHz 0.00 kHz <td></td> <td></td> <td></td> <td>Sweep Setup ►</td> <td>10 dB/dlv Ref 30.00 dBm Log 200 100 200 400 300 300 300 300 400 400 4</td> <td></td> <td></td> <td>Auto N Sweep Setu Pau</td>				Sweep Setup ►	10 dB/dlv Ref 30.00 dBm Log 200 100 200 400 300 300 300 300 400 400 4			Auto N Sweep Setu Pau
24.462 kHz Control 25.808 kHz Control Transmit Freq Error 408 Hz OBW Power 99.00 % Transmit Freq Error 504 Hz OBW Power 99.00 % x dB Bandwidth 27.02 kHz x dB 20.00 dB Points x dB Bandwidth 25.02 kHz x dB 20.00 dB Points	Res BW 10 kHz		Sweep 2.533 ms	Gate	#Res BW 10 kHz		Sweep 2.533 ms	
	24 Transmit Freq Error	408 Hz OBW Power	99.00 %	[Off, LO]	25 Transmit Freq Error	504 Hz OBW Power	99.00 %	Gat [Off, LC Poir 10

5.2. Frequency Stability

Ambient condition

Temperature	Relative humidity
21°C ~25°C	40%~60%

Method of Measurement

1. Frequency Stability (Temperature Variation)

The temperature inside the climate chamber is varied from -20°C to +45°C in 10°C step size, (1) With all power removed, the temperature was decreased to 0°C and permitted to stabilize for three hours.

(2) Measure the carrier frequency with the test equipment in a "call mode". These measurements should be made within 1 minute of powering up the mobile station, to prevent significant self warming.

(3) Repeat the above measurements at 10°C increments from -20°C to +45°C. Allow at least 1.5 hours at each temperature, un-powered, before making measurements.

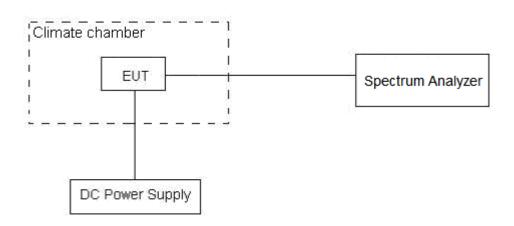
2. Frequency Stability (Voltage Variation)

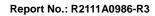
which shall be specified by the manufacturer.

The frequency stability shall be measured with variation of primary supply voltage as follows: **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point

This transceiver is specified to operate with an input voltage of between 3.5 V and 4.4 V, with a nominal voltage of 3.82V.

Test setup







Rule Part 15.225 (e) The frequency tolerance of the carrier signal shall be maintained within $\pm 0.01\%$ of the operating frequency over a temperature variation of -20 degrees to +50 degrees C at normal supply voltage, and for a variation in the primary supply voltage from 85% to 115% of the rated supply voltage at a temperature of 20 degrees C. For battery operated equipment, the equipment tests shall be performed using a new battery.

Measurement Uncertainty

The assessed measurement uncertainty to ensure 99.75% confidence level for the normal distribution is with the coverage factor k = 3, U = 0.01 ppm.



Test Result

NFC-A

Teet		Frequ	uency		Toloran	ce (MHz)		
Test		13.56	6MHz			TOleran		
status	1min	2min	5min	10min	1min	2min	5min	10min
-20°C/3.82V	13.559342	13.559343	13.559348	13.559345	0.000658	0.000657	0.000652	0.000655
-10°C/3.82V	13.559338	13.559341	13.559339	13.559344	0.000662	0.000659	0.000661	0.000656
0°C/3.82V	13.559335	13.559335	13.559332	13.559340	0.000665	0.000665	0.000668	0.000660
10°C/3.82V	13.559333	13.559330	13.559329	13.559335	0.000667	0.000670	0.000671	0.000665
20°C/3.82V	13.559331	13.559327	13.559325	13.559333	0.000669	0.000673	0.000675	0.000667
30°C/3.82V	13.559325	13.559318	13.559318	13.559327	0.000675	0.000682	0.000682	0.000673
40°C/3.82V	13.559319	13.559317	13.559311	13.559327	0.000681	0.000683	0.000689	0.000673
45°C/3.82V	13.559310	13.559310	13.559303	13.559324	0.000690	0.000690	0.000697	0.000676
20°C/3.5V	13.559302	13.559309	13.559297	13.559316	0.000698	0.000691	0.000703	0.000684
20°C/4.4V	13.559300	13.559303	13.559297	13.559312	0.000700	0.000697	0.000703	0.000688

Test		Tolera	nce (%)		1 implif $(0/)$	Conclusion
status	1min	2min	5min	10min	Limit (%)	Conclusion
-20°C/3.82V	0.004796	0.004858	0.004781	0.004900	0.01	PASS
-10°C/3.82V	0.004825	0.004905	0.004846	0.004911	0.01	PASS
0°C/3.82V	0.004896	0.004974	0.004894	0.004922	0.01	PASS
10°C/3.82V	0.004917	0.005003	0.004909	0.004987	0.01	PASS
20°C/3.82V	0.004953	0.005041	0.004909	0.005039	0.01	PASS
30°C/3.82V	0.004992	0.005042	0.004916	0.005112	0.01	PASS
40°C/3.82V	0.005007	0.005071	0.004971	0.005172	0.01	PASS
45°C/3.82V	0.005024	0.005117	0.005008	0.005175	0.01	PASS
20°C/3.5V	0.005085	0.005126	0.005060	0.005189	0.01	PASS
20°C/4.4V	0.005089	0.005168	0.005131	0.005190	0.01	PASS

NFC-B

Test		Frequ	iency		Toloran	oo (MЦ ,)		
Test		13.56	MHz	-		Tolerand	ce (MHz)	
status	1min	2min	5min	10min	1min	2min	5min	10min
-20°C/3.82V	13.559349	13.559336	13.559338	13.559341	0.000651	0.000664	0.000662	0.000659
-10°C/3.82V	13.559341	13.559334	13.559337	13.559340	0.000659	0.000666	0.000663	0.000660
0°C/3.82V	13.559339	13.559325	13.559329	13.559336	0.000661	0.000675	0.000671	0.000664
10°C/3.82V	13.559336	13.559319	13.559322	13.559328	0.000664	0.000681	0.000678	0.000672
20°C/3.82V	13.559328	13.559314	13.559317	13.559320	0.000672	0.000686	0.000683	0.000680
30°C/3.82V	13.559325	13.559312	13.559311	13.559320	0.000675	0.000688	0.000689	0.000680
40°C/3.82V	13.559320	13.559304	13.559305	13.559318	0.000680	0.000696	0.000695	0.000682
45°C/3.82V	13.559317	13.559297	13.559298	13.559311	0.000683	0.000703	0.000702	0.000689
20°C/3.5V	13.559312	13.559291	13.559294	13.559305	0.000688	0.000709	0.000706	0.000695
20°C/4.4V	13.559310	13.559286	13.559285	13.559297	0.000690	0.000714	0.000715	0.000703

Test		Tolera		Limit(%)	Conclusion	
status	1min	2min	5min	10min		Conclusion
-20°C/3.82V	0.004900	0.004824	0.004880	0.004899	0.01	PASS
-10°C/3.82V	0.004931	0.004855	0.004925	0.004937	0.01	PASS
0°C/3.82V	0.004998	0.004892	0.004961	0.004995	0.01	PASS
10°C/3.82V	0.005062	0.004929	0.005006	0.005027	0.01	PASS
20°C/3.82V	0.005124	0.004967	0.005008	0.005067	0.01	PASS
30°C/3.82V	0.005191	0.005034	0.005014	0.005130	0.01	PASS
40°C/3.82V	0.005263	0.005097	0.005017	0.005193	0.01	PASS
45°C/3.82V	0.005303	0.005147	0.005073	0.005258	0.01	PASS
20°C/3.5V	0.005371	0.005151	0.005105	0.005297	0.01	PASS
20°C/4.4V	0.005412	0.005164	0.005121	0.005356	0.01	PASS

NFC-F

Test		Frequ		Toloran	Tolerance (MHz)			
Test		13.56	MHz			TOleran		
status	1min	2min	5min	10min	1min	2min	5min	10min
-20°C/3.82V	13.559351	13.559353	13.559344	13.559334	0.000649	0.000647	0.000656	0.000666
-10°C/3.82V	13.559343	13.559346	13.559343	13.559327	0.000657	0.000654	0.000657	0.000673
0°C/3.82V	13.559338	13.559341	13.559341	13.559323	0.000662	0.000659	0.000659	0.000677
10°C/3.82V	13.559333	13.559335	13.559334	13.559320	0.000667	0.000665	0.000666	0.000680
20°C/3.82V	13.559332	13.559331	13.559334	13.559317	0.000668	0.000669	0.000666	0.000683
30°C/3.82V	13.559330	13.559330	13.559327	13.559311	0.000670	0.000670	0.000673	0.000689
40°C/3.82V	13.559329	13.559328	13.559323	13.559306	0.000671	0.000672	0.000677	0.000694
45°C/3.82V	13.559323	13.559319	13.559315	13.559303	0.000677	0.000681	0.000685	0.000697
20°C/3.5V	13.559315	13.559310	13.559307	13.559294	0.000685	0.000690	0.000693	0.000706
20°C/4.4V	13.559306	13.559302	13.559303	13.559288	0.000694	0.000698	0.000697	0.000712

Test		Tolera		Limit(%)	Conclusion	
status	1min	2min	5min	10min		Conclusion
-20°C/3.82V	0.004871	0.004813	0.004836	0.004772	0.01	PASS
-10°C/3.82V	0.004902	0.004865	0.004886	0.004824	0.01	PASS
0°C/3.82V	0.004945	0.004904	0.004915	0.004890	0.01	PASS
10°C/3.82V	0.004988	0.004963	0.004970	0.004924	0.01	PASS
20°C/3.82V	0.005054	0.005018	0.004988	0.004995	0.01	PASS
30°C/3.82V	0.005058	0.005026	0.005055	0.005025	0.01	PASS
40°C/3.82V	0.005071	0.005070	0.005101	0.005036	0.01	PASS
45°C/3.82V	0.005101	0.005076	0.005156	0.005109	0.01	PASS
20°C/3.5V	0.005156	0.005139	0.005159	0.005132	0.01	PASS
20°C/4.4V	0.005208	0.005144	0.005188	0.005174	0.01	PASS



NFC-V

Test		Frequ	iency		Toloron			
Test		13.56	MHz			Tolerand	ce (MHz)	
status	1min	2min	5min	10min	1min	2min	5min	10min
-20°C/3.82V	13.559337	13.559349	13.559347	13.559341	0.000663	0.000651	0.000653	0.000659
-10°C/3.82V	13.559330	13.559342	13.559343	13.559336	0.000670	0.000658	0.000657	0.000664
0°C/3.82V	13.559320	13.559338	13.559342	13.559329	0.000680	0.000662	0.000658	0.000671
10°C/3.82V	13.559310	13.559331	13.559333	13.559327	0.000690	0.000669	0.000667	0.000673
20°C/3.82V	13.559310	13.559328	13.559332	13.559325	0.000690	0.000672	0.000668	0.000675
30°C/3.82V	13.559307	13.559320	13.559323	13.559323	0.000693	0.000680	0.000677	0.000677
40°C/3.82V	13.559307	13.559316	13.559313	13.559321	0.000693	0.000684	0.000687	0.000679
45°C/3.82V	13.559301	13.559316	13.559306	13.559321	0.000699	0.000684	0.000694	0.000679
20°C/3.5V	13.559293	13.559309	13.559297	13.559317	0.000707	0.000691	0.000703	0.000683
20°C/4.4V	13.559286	13.559303	13.559295	13.559309	0.000714	0.000697	0.000705	0.000691

Test		Tolera		Limit(%)	Conclusion	
status	1min	2min	5min	10min		Conclusion
-20°C/3.82V	0.004914	0.004908	0.004809	0.004791	0.01	PASS
-10°C/3.82V	0.004946	0.004954	0.004880	0.004861	0.01	PASS
0°C/3.82V	0.005004	0.005023	0.004935	0.004918	0.01	PASS
10°C/3.82V	0.005048	0.005077	0.005003	0.004948	0.01	PASS
20°C/3.82V	0.005063	0.005132	0.005033	0.004977	0.01	PASS
30°C/3.82V	0.005064	0.005133	0.005058	0.005029	0.01	PASS
40°C/3.82V	0.005134	0.005186	0.005094	0.005100	0.01	PASS
45°C/3.82V	0.005135	0.005202	0.005119	0.005145	0.01	PASS
20°C/3.5V	0.005206	0.005219	0.005178	0.005193	0.01	PASS
20°C/4.4V	0.005270	0.005230	0.005212	0.005259	0.01	PASS



5.3. Radiates Emission

Ambient condition

Temperature	ture Relative humidity Press	
23°C ~25°C	45%~50%	102.5kPa

Method of Measurement

The test set-up was made in accordance to the general provisions of ANSI C63.10. The Equipment Under Test (EUT) was set up on a non-conductive table in the semi-anechoic chamber. The test was performed at the distance of 3 m between the EUT and the receiving antenna. The radiated emissions measurements were made in a typical installation configuration.

Sweep the whole frequency band through the range from 9 kHz to the 10th harmonic of the carrier, and the emissions less than 20 dB below the permissible value are reported.

During the test, below 30MHz, the center of the loop shall be 1 meters; above 30MHz, the height of receive antenna shall be moved from 1 to 4 meters, and the antenna shall be performed under horizontal and vertical polarization. The turntable shall be rotated from 0 to 360 degrees for detecting the maximum of radiated spurious signal level. The measurements shall be repeated with orthogonal polarization of the test antenna. The data of cable loss and antenna factor has been calibrated in full testing frequency range before the testing.

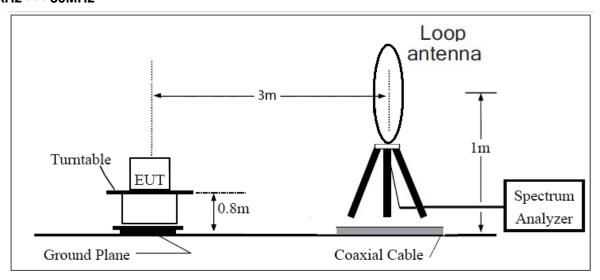
Set the spectrum analyzer in the following:

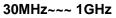
Out-of-band Below30MHz RBW=9KHz, VBW=30KHz, detector=peak; Above 30MHz, RBW=100KHz, VBW=300KHz, Detector=peak In-band RBW=9KHz, VBW=30KHz, detector=peak;

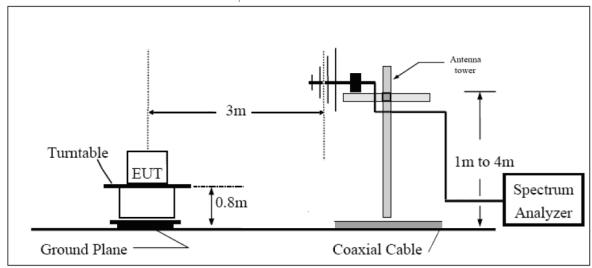
The field strength of spurious emission was measured in the following position: EUT stand-up position (Z axis), lie-down position (X, Y axis). The worst emission was found in lie-down position (X axis) and the loop antenna is vertical, the other antennas are vertical and horizontal.



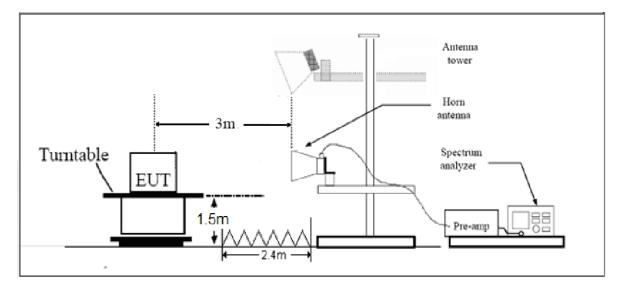
Test setup 9kHz~~~ 30MHz







Above 1GHz



Note: Area side:2.4mX3.6m



Limits

Clause 15.225(a) the field strength of any emissions within the band 13.553-13.567 MHz shall not exceed 15,848 microvolts/meter at 30 meters.

Clause 15.225(b) within the bands 13.410-13.553 MHz and 13.567-13.710 MHz, the field strength of any emissions shall not exceed 334 microvolts/meter at 30 meters.

Clause 15.225(c) within the bands 13.110-13.410 MHz and 13.710-14.010 MHz the field strength of any emissions shall not exceed 106 microvolts/meter at 30 meters.

Clause 15.225(d) The field strength of any emissions appearing outside of the 13.110-14.010 MHz band shall not exceed the general radiated emission limits in §15.209.

§15.209 (a) Except as provided elsewhere in this subpart, the emissions from an intentional radiator shall not exceed the field strength levels specified in the following table:

Frequency of emission (MHz)	Field strength(uV/m)	Field strength(dBuV/m)
0.009–0.490	2400/F(kHz)	128.519dBuV/m -93.8dBuV/m
0.490–1.705	24000/F(kHz)	73.8dBuV/m - 62.969dBuV/m
1.705–30.0	30	69.5 dBuV/m
30-88	100	40 dBuV/m
88-216	150	43.5 dBuV/m
216-960	200	46 dBuV/m
Above960	500	54 dBuV/m

When using other measurement distance, according to the standard C63.10, If that point is closer to the EUT than $\lambda/2\pi$ and the limit distance is greater than $\lambda/2\pi$, the data was extrapolated to the specified measurement distance of 30m using extrapolation factor as specified in §6.4.4.2. Extrapolation Factor = 40log(d near filed/ d measure)+20log(d limit / d near filed) **Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§15.231 and 15.241.

§15.209 (b) In the emission table above, the tighter limit applies at the band edges.

§15.209 (d) The emission limits shown in the above table are based on measurements employing a CISPR quasi-peak detector except for the frequency bands 9-90 kHz, 110-490 kHz and above 1000 MHz. Radiated emission limits in these three bands are based on measurements employing an average detector.

Measurement Uncertainty

The assessed measurement uncertainty to ensure 95% confidence level for the normal distribution is with the coverage factor k = 1.96.

Frequency	Uncertainty
9KHz-30MHz	3.55 dB
30MHz-200MHz	4.02 dB
200MHz-1GHz	3.28 dB
Above 1GHz	3.70 dB

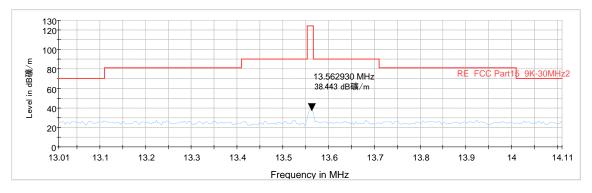


Test result

The test is in transmitting all mode, NFC-A was selected as the worst condition. The test data of the worst-case condition was recorded in this report.

A font (dB m)in the test plot =($dB\mu V/m$)

In-band



Radiates Emission from 13.11MHz to 14.01MHz Note: This graph displays the maximum values of horizontal and vertical by software

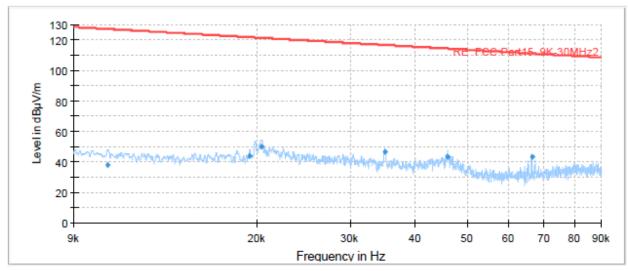


Out-of-band

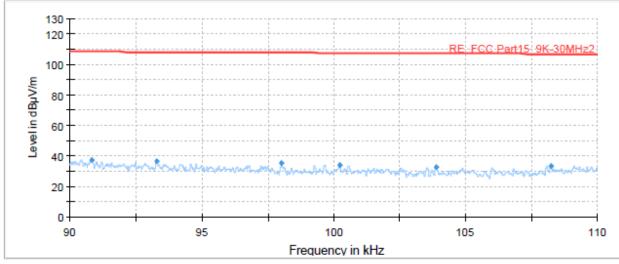
The test is in transmitting all modes, NFC-A was selected as the worst condition. The test data of the worst-case condition was recorded in this report.

The following graphs display the maximum values of horizontal and vertical by software.

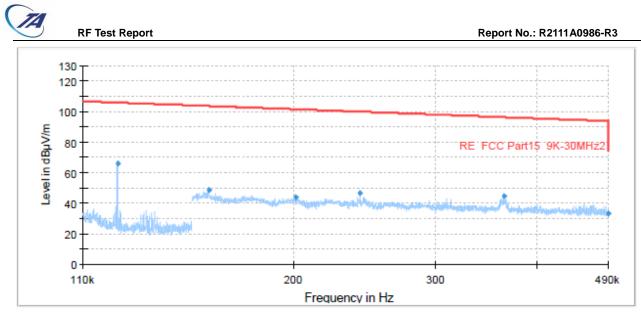
For above 1GHz, Blue trace uses the peak detection, Green trace uses the average detection.

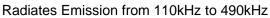


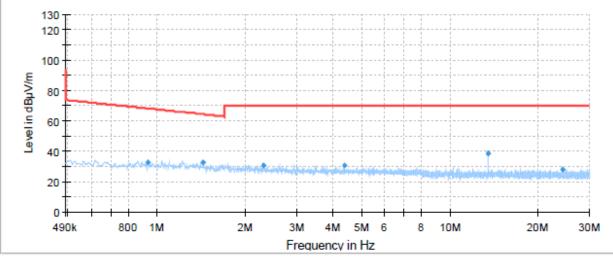
Radiates Emission from 9kHz to 90kHz



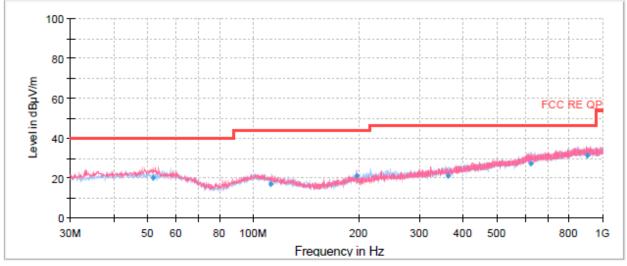
Radiates Emission from 90kHz to 110kHz







Radiates Emission from 490kHz to 30MHz



Radiates Emission from 30MHz to 1GHz

Note: This graph displays the maximum values of horizontal and vertical by software



Frequency (MHz)	Quasi-Peak (dBuV/m)	Height (cm)	Polarization	Azimuth (deg)	Correct Factor (dB)	Margin (dB)	Limit (dBuV/m)
51.805231	19.94	113.0	V	9.0	14	20.06	40.00
111.849750	16.74	225.0	Н	236.0	12	26.76	43.50
197.981750	21.19	225.0	V	336.0	12	22.31	43.50
361.417250	21.24	175.0	Н	112.0	16	24.76	46.00
620.798000	27.24	175.0	Н	62.0	22	18.76	46.00
904.308750	31.04	105.0	V	79.0	25	14.96	46.00



5.4. Conducted Emission

Ambient condition

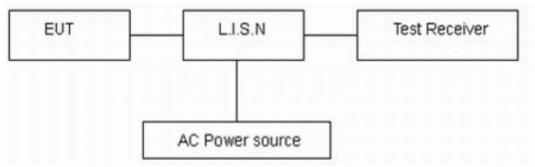
Temperature	Relative humidity	Pressure		
23°C ~25°C	45%~50%	101.5kPa		

Methods of Measurement

The EUT is placed on a non-metallic table of 80cm height above the horizontal metal reference ground plane. During the test, the EUT was operating in its typical mode. The test method is according to ANSI C63.10. Connect the AC power line of the EUT to the L.I.S.N. Use EMI receiver to detect the average and Quasi-peak value. RBW is set to 9 kHz, VBW is set to 30kHz. The measurement result should include both L line and N line.

The test is in transmitting mode.

Test Setup



Note: AC Power source is used to change the voltage 110V/60Hz.

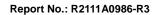
Limits

§15.207 (a) Except as shown in paragraphs (b) and (c) of this section, for an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies, within the band 150 kHz to 30 MHz, shall not exceed the limits in the following table, as measured using a 50 μ H/50 ohms line impedance stabilization network (LISN). Compliance with the provisions of this paragraph shall be based on the measurement of the radio frequency voltage between each power line and ground at the power terminal. The lower limit applies at the boundary between the frequency ranges.

Frequency	Conducted Limits(dBµV)						
(MHz)	Quasi-peak	Average					
0.15 - 0.5	66 to 56 [*]	56 to 46 [*]					
0.5 - 5	56	46					
5 - 30	60	50					
* Decreases with the logarithm of the frequency.							

Measurement Uncertainty

The assessed measurement uncertainty to ensure 95% confidence level for the normal distribution is with the coverage factor k = 1.96, U= 2.69 dB.

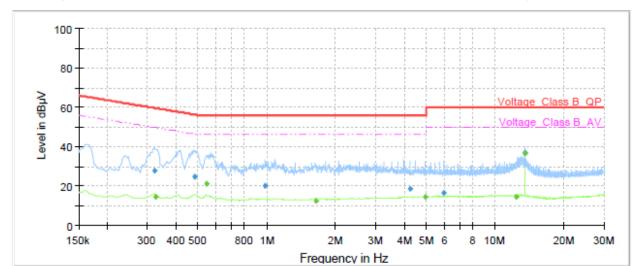




Test Results:

The test is in transmitting all mode, NFC-A was selected as the worst condition. The test data of the worst-case condition was recorded in this report.

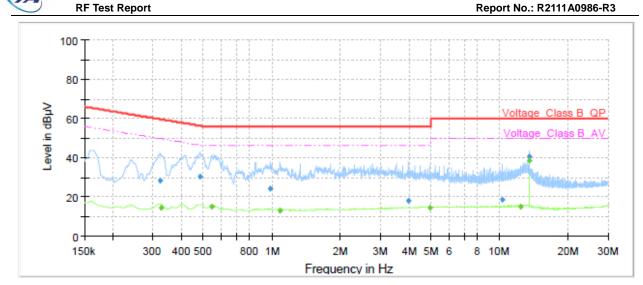
Following plots, Blue trace uses the peak detection and Green trace uses the average detection.



Frequency (MHz)	QuasiPeak (dBµV)	Average (dBµV)	Limit (dBµV)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Line	Filter	Corr. (dB)
0.32	27.59		59.62	32.03	70.0	9.000	L1	ON	21
0.33		14.38	49.57	35.19	70.0	9.000	L1	ON	21
0.49	24.60		56.25	31.65	70.0	9.000	L1	ON	20
0.54		20.97	46.00	25.03	70.0	9.000	L1	ON	20
0.99	20.02		56.00	35.98	70.0	9.000	L1	ON	20
1.63		12.45	46.00	33.55	70.0	9.000	L1	ON	20
4.24	18.38		56.00	37.62	70.0	9.000	L1	ON	19
4.97		14.36	46.00	31.64	70.0	9.000	L1	ON	19
5.93	16.54		60.00	43.46	70.0	9.000	L1	ON	19
12.35		14.28	50.00	35.72	70.0	9.000	L1	ON	20
13.56		36.56	50.00	13.44	70.0	9.000	L1	ON	20
13.56	36.80		60.00	23.20	70.0	9.000	L1	ON	20

Remark: Correct factor=cable loss + LISN factor

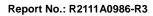
L line Conducted Emission from 150 KHz to 30 MHz



Frequency (MHz)	QuasiPeak (dBµV)	Average (dBμV)	Limit (dBµV)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Line	Filter	Corr. (dB)
0.32	27.97		59.62	31.65	70.0	9.000	Ν	ON	21
0.33		14.50	49.57	35.07	70.0	9.000	Ν	ON	21
0.48	30.15		56.33	26.18	70.0	9.000	Ν	ON	20
0.54		14.95	46.00	31.05	70.0	9.000	Ν	ON	20
0.98	24.10		56.00	31.90	70.0	9.000	Ν	ON	20
1.09		12.83	46.00	33.17	70.0	9.000	Ν	ON	20
3.99	18.16		56.00	37.84	70.0	9.000	Ν	ON	19
4.96		14.27	46.00	31.73	70.0	9.000	Ν	ON	19
10.28	18.32		60.00	41.68	70.0	9.000	Ν	ON	20
12.34		14.72	50.00	35.28	70.0	9.000	Ν	ON	20
13.56		38.49	50.00	11.51	70.0	9.000	Ν	ON	20
13.56	40.77		60.00	19.23	70.0	9.000	Ν	ON	20

Remark: Correct factor=cable loss + LISN factor

N line Conducted Emission from 150 KHz to 30 MHz





6. Main Test Instruments

Name	Manufacturer	Туре	Serial Number	Calibration Date	Expiration Time	
Spectrum Analyzer	R&S	FSV30	100815	2020-12-13	2021-12-12	
EMI Test Receiver	R&S	ESCI	100948	2021-05-15	2022-05-14	
Loop Antenna	SCHWARZBECK	FMZB1519	1519-047	2020-04-02	2023-04-01	
TRILOG Broadband Antenna	SCHWARZBECK	VULB 9163	391	2019-12-16	2022-12-15	
EMI Test Receiver	R&S	ESR	101667	2021-05-16	2022-05-15	
LISN	R&S	ENV216	101171	2018-12-15	2021-12-14	
Spectrum Analyzer	Agilent	N9020A	MY52330084	2021-05-15	2022-05-14	
TEMPERATURE CHAMBER	WEISS	VT4002	582261194500 10	2021-5-15	2022-5-14	
RF Cable	Agilent	SMA 15cm	0001	2021-06-13	2021-12-12	
Software	R&S	EMC32	9.26.0	/	/	

******END OF REPORT ******



ANNEX A: The EUT Appearance

The EUT Appearance are submitted separately.



ANNEX B: Test Setup Photos

The Test Setup Photos are submitted separately.